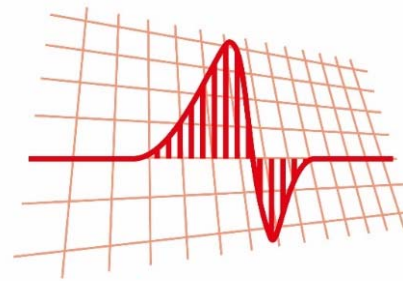


**STK - Swiss Society
for Thermal Analysis
and Calorimetry**

Prof. Pierre Brodard
President

Dr. Angela Hammer
Vice-President

Nänikon, 24.11.2020



STK

Welcome address

STK online meeting 2020

METTLER TOLEDO

The logo graphic for Mettler Toledo, featuring a series of parallel green lines that form a stylized, elongated shape, possibly representing a balance scale or a measurement instrument. The lines are arranged in a way that they appear to converge and diverge, creating a sense of depth and movement.

1 Program

2 Rules

3 Copyright

14:00 Introduction by Pierre Brodard & Angela Hammer

14:10 Part 1: 2 x 30 minutes

1. Dr. Jörg Woerlitschek/Dr. Lukas Müller, Hochschule Luzern, **Phase Change Materials**
2. Dr. Jürgen Schawe, Mettler-Toledo Schweiz, **Determination of thermodynamic properties of polymorphic systems with fast crystallization kinetics**

15:10 Break and additional Q&A to speakers 1 and 2

15:20 Part 2: 3 x 20 minutes

3. Delphine Berset, TÜV SÜD Schweiz, **Calorimetric Studies and Process Safety**
4. Caitlin Blum, HEIA-FR Haute école d'ingénierie et d'architecture Fribourg, **Custom-made ml-scale Reaction Calorimeter for thermal safety screening purposes**
5. Dr. Angela Hammer, Mettler-Toledo Schweiz, **Energy Storage**

16:20 Final Q&A to speakers 3, 4 and 5

16:25 Farewell by Pierre Brodard & Angela Hammer

16:30 END OF THE MEETING



Please help us to make the meeting a success !

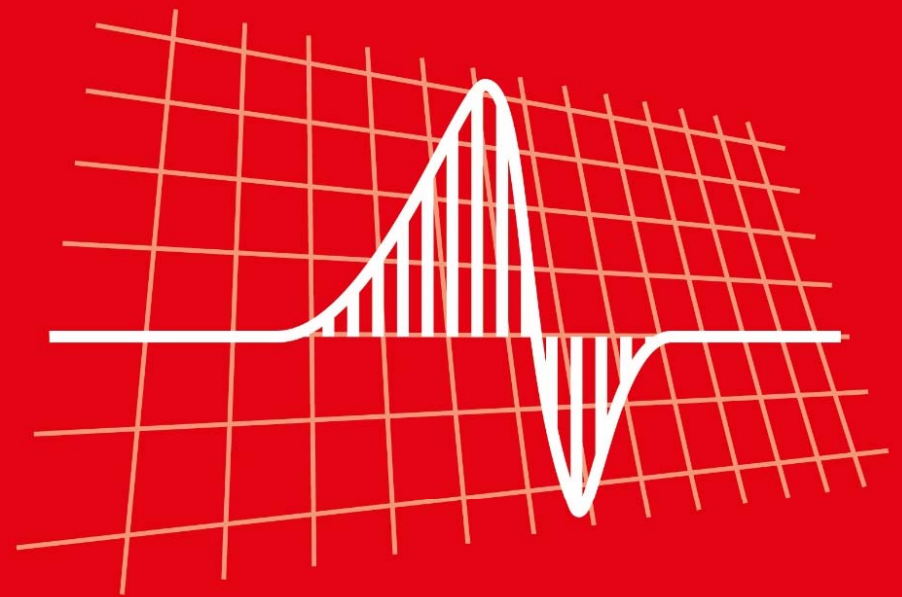
- All microphones go to mute
- Cameras should be turned off
- No questions during the presentations
- After the presentations, please use the chat for questions
- The speakers will answer orally for the whole audience



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- Thanks a lot !



Thank you & have a good
meeting !



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P. Brodard & A. Hammer